



IFW

03500.017825.

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)	Examiner: James D. Stein
TATSUYA IWASAKI)	
Application No.: 10/533,564)	Group Art Unit: 2874
371(c) Date: May 3, 2005)	
For: PROCESS OF INFORMATION)	
TRANSMISSION IN OPTICAL)	
CIRCUIT DEVICE AND OPTICAL)	
CIRCUIT DEVICE THEREFOR)	June 7, 2006

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents below and listed on the enclosed Form PTO-1449.

- (1) U.S. Publication No. 2005-0129348 A1
- (2) U.S. Patent No. 6,278,231
- (3) U.S. Patent No. 6,838,297
- (4) U.S. Patent No. 5,357,122
- (5) U.S. Patent No. 5,191,219
- (6) WO 2004/093354 A1

- (7) Hideo Itoh, et al., "Multidimensional Optical Interconnections Using Beam-Scanning Laser Diodes", Electronics and Communications in Japan, Part II: Electronics, Scripta Technica, New York, U.S., Vol. 75, No. 11, (11/01/1992), pp. 32-41, XP000381545, ISSN: 8756-663X.

The Examiner's attention is also directed to the following co-pending Application which has been assigned in common with the present application:

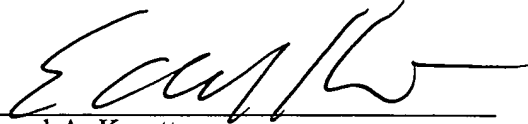
<u>Application No.</u>	<u>Filing Date</u>	<u>Group Art Unit</u>	<u>Inventor</u>
10/530,188	April 4, 2005	2883	Tatsuya Iwasaki

It is noted that the foregoing application has not been published under 35 U.S.C. § 122. However, the application is currently available in the Patent Office's Image File Wrapper. Therefore, in accordance with Official Gazette Notice 1287 O.G. 163 (Oct. 19, 2004), a copy of the foregoing U.S. Application is not being provided herewith. In addition, document (6) is believed to be an international application corresponding to U.S. Application No. 10/530,188.

Inasmuch as the subject application has not yet received a first Office Action on the merits, it is believed that this Information Disclosure Statement is timely. See 37 C.F.R. § 1.97(b)(3). Accordingly, the Examiner is urged to study this information in its entirety and to form an independent determination of the materiality of the information to the claimed invention. Additionally, the Examiner is requested to indicate that this information has been considered by initialing the appropriate portion of Form PTO-1449.

Applicant's undersigned attorney may be reached in our Costa Mesa, California office by telephone at (714) 540-8700. All correspondence should continue to be directed to our address given below.

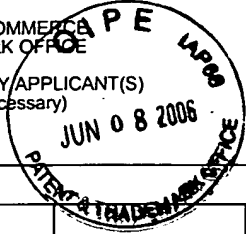
Respectfully submitted,

A handwritten signature in black ink, appearing to read 'E. Kmett', written over a horizontal line.

Edward A. Kmett
Attorney for Applicant
Registration No.: 42,746

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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 03500.017825		APPLICATION NO. 10/533,564		
			APPLICANT TATSUYA IWASAKI				
			FILING DATE 371(c) Date: May 3, 2005		GROUP 2874		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		2005/0129348	06/16/2005	Iwasaki	385	14	
		6,278,231	08/21/2001	Iwasaki, et al.	313	310	
		6,838,297	01/04/2005	Iwasaki, et al.	438	20	
		5,357,122	10/18/1994	Okubora, et al.	257	84	
		5,191,219	03/02/1993	Linke	250	551	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
		2004/093354	10/28/2004	PCT/WO			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
		Hideo Itoh, et al., "Multidimensional Optical Interconnections Using Beam-Scanning Laser Diodes", Electronics and Communications in Japan, Part II: Electronics, Scripta Technica, New York, U.S., Vol. 75, No. 11, (11/01/1992), pp. 32-41, XP000381545, ISSN: 8756-663X.					
EXAMINER				DATE CONSIDERED			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1